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Power Field Effect Transistor N-Channel Enhancement-Mode Silicon Gate

This TMOS Power FET is designed for high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds Switching Times Specified at 100°C
- Designer's Data IDSS, VDS(on), VGS(th) and SOA Specified at Elevated Temperature
- Rugged SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads

MAXIMUM RATINGS

HAAIMUM HAIINGS				
Rating	Symbol	Value		Unit
Drain-Source Voltae	VDSS	100		Vdc
Drain-Gate Voltage (R _{GS} = 1 MΩ)	VDGR	100		Vdc
Gate-Source Voltage Continuous Non-repetitive (t _P ≤ 50 μs)	V _{GS} V _{GSM}	± 20 ± 40		Vdc Vpk
Drain Current — Continuous — Pulsed	ID IDM	25 105		Adc
Total Power Dissipation @ T _C = 25°C Derate above 25°C	PD	150 1.2		Watts W/°C
Operating and Storage Temperature Range	Tj, T _{stg}	-65 to 150		°C
HERMAL CHARACTERISTICS				
Thermal Resistance — Junction to Case — Junction to Ambient	R _{ØJC} R _{ØJA}	0.83 30		°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	ΤL	300		°C
ELECTRICAL CHARACTERISTICS	25°C unless othe	erwise note	d)	
Characteristic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS			•	
Drain-Source Breakdown Voltage (V _{GS} = 0, I _D = 0.25 mA)	V(BR)DSS	100	_	Vdc
Zero Gate Voltage Drain Current $(V_{DS} = Rated V_{DSS}, V_{GS} = 0)$ $(V_{DS} = Rated V_{DSS}, V_{GS} = 0, T_J = 125^{\circ}C)$	IDSS		10 100	µAdc





MTM25N10







NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

100

100

nAdc

nAdc

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IGSSF

^IGSSR

Quality Semi-Conductors

Gate-Body Leakage Current, Forward

 $(V_{GSF} = 20 \text{ Vdc}, V_{DS} = 0)$ Gate-Body Leakage Current, Reverse

 $(V_{GSR} = 20 \text{ Vdc}, V_{DS} = 0)$

ELECTRICAL	CHARACTERISTICS -	continued ($T_{C} =$	25°C unless otherwise noted)
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Characteristic		Symbol	Min	Max	Unit
IN CHARACTERISTICS*					
Gate Threshold Voltage (VDS = VGS, ID = 1 mA) TJ = 100°C		VGS(th)	2 15	4.5 4	Vdc
Static Drain-Source On-Resistance (VGS = 10 Vdc, ID = 12.5 Adc)		R _{DS(on)}	-	0.075	Ohm
Drain-Source On-Voltage (V _{GS} = 10 V) (I _D = 25 Adc) (I _D = 12.5 Adc, T _J = 100°C)		VDS(on)		2.25 1.8	Vde
Forward Transconductance (V _{DS} = 10 V, I _D = 12.5 A)		9FS	5		mhos
YNAMIC CHARACTERISTICS					
Input Capacitance	$(V_{DS} = 25 V, V_{GS} = 0,$	Ciss		2000	pF
Output Capacitance	f = 1 MHz)	Coss		1500	
Reverse Transfer Capacitance	See Figure 11	Crss	-	400	
WITCHING CHARACTERISTICS* (TJ	⇔ 100°C)				
Turn-On Delay Time		td(on)	_	60	ns
Rise Time	$(V_{DD} = 25 \text{ V}, I_D = 0.5 \text{ Rated } I_D$	tr	—	450	
Turn-Off Delay Time	 R_{gen} = 50 ohms) See Figures 9, 13 and 14 	td(off)		150	
Fall Time		tf	_	300	
Total Gate Charge	(V _{DS} = 0.8 Rated V _{DSS} ,	٥g	29 (Typ)	40	nC
Gate-Source Charge	ID = Rated ID, VGS = 10 V)	Qgs	23 (Typ)	_	
Gate-Drain Charge	See Figure 12	Qgd	6 (Түр)		
OURCE DRAIN DIODE CHARACTERI	STICS*				
Forward On-Voltage	(Is = Rated ID	VSD	1.5 (Typ)	1.8	Vdc
Forward Turn-On Time	$V_{GS} = 0$	ton	Limited by stray inductance		
Reverse Recovery Time		t _{rr}	450 (Typ)	 _	ns
NTERNAL PACKAGE INDUCTANCE (TO-204)				
Internal Drain Inductance (Measured from the contact screw on the header closer to the source pin and the center of the die)		La	5 (Түр)		nH
Internal Source Inductance (Measured from the source pin, 0 to the source bond pad)).25" from the package	Ls	12.5 (Typ)		